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Fairchild Semiconductor FQD10N20CTF

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November 2013

FQD10N20C / FQU10N20C

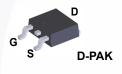
N-Channel QFET[®] MOSFET 200 V, 7.8 A, 360 m Ω

Features

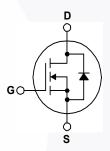
- 7.8 A, 200 V, $R_{DS(on)}$ = 360 m Ω (Max.) @ V_{GS} = 10 V, I_D = 3.9 A
- Low Gate Charge (Typ. 20 nC)
- Low Crss (Typ. 40.5 pF)
- · 100% Avalanche Tested

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

| Symbol | Parameter | | FQD10N20CTM / FQU10N20CTU | Unit |
|-----------------------------------|---|----------|---------------------------|------|
| V _{DSS} | Drain-Source Voltage | | 200 | V |
| I _D | Drain Current - Continuous (T _C = 25°C) | | 7.8 | Α |
| | - Continuous (T _C = 100°C) | | 5.0 | Α |
| I _{DM} | Drain Current - Pulsed | (Note 1) | 31.2 | Α |
| V _{GSS} | Gate-Source Voltage | | ± 30 | V |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | 210 | mJ |
| I _{AR} | Avalanche Current | (Note 1) | 7.8 | Α |
| E _{AR} | Repetitive Avalanche Energy | | 5.0 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | 5.5 | V/ns |
| P _D | Power Dissipation (T _C = 25°C) | | 50 | W |
| | - Derate above 25°C | | 0.4 | W/°C |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C |
| TL | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C |
| | | | 300 | |

Thermal Characteristics

| Symbol | Parameter | FQD10N20CTM / FQU10N20CTU | Unit |
|-----------------|--|---------------------------|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case, Max. 2.5 | | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient, Max. | 110 | C/ W |



Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-------------|---------|-----------|------------|------------|
| FQD10N20C | FQD10N20CTM | D-PAK | 330 mm | 16 mm | 2500 units |
| FQU10N20C | FQU10N20CTU | I-PAK | Tube | N/A | 70 units |

Electrical Characteristics $T_C = 25$ °C unless otherwise noted.

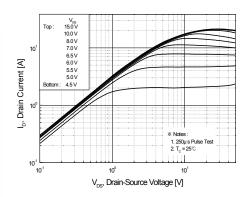
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|------------------------------------|---|--|-----|------|------|------|
| Off Cha | racteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 200 | | | V |
| ΔBV_{DSS} / ΔT_{J} | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | - | 0.28 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 200 V, V _{GS} = 0 V | - | | 10 | μΑ |
| | | V _{DS} = 160 V, T _C = 125°C | | | 100 | μΑ |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | | | -100 | nA |
| On Cha | racteristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 2.0 | | 4.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D = 3.9 A | \ | 0.29 | 0.36 | Ω |
| g _{FS} | Forward Transconductance | V _{DS} = 40 V, I _D = 3.9 A | | 5.6 | | S |
| | ic Characteristics | | | | 1 | |
| C _{iss} | Input Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ | | 395 | 510 | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 97 | 125 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 40.5 | 53 | pF |
| Switchi | ng Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 100 V, I _D = 9.5 A, | | 11 | 30 | ns |
| t _r | Turn-On Rise Time | $R_G = 25 \Omega$ | | 92 | 190 | ns |
| t _{d(off)} | Turn-Off Delay Time | | // | 70 | 150 | ns |
| t _f | Turn-Off Fall Time | (Note 4) | | 72 | 160 | ns |
| Qg | Total Gate Charge | V _{DS} = 160 V, I _D = 9.5 A, | / | 20 | 26 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = 10 V | | 3.1 | | nC |
| Q_{gd} | Gate-Drain Charge | (Note 4) | | 10.5 | | nC |
| Drain-S | ource Diode Characteristics ar | nd Maximum Ratings | | | | |
| I _S | Maximum Continuous Drain-Source Diode Forward Current | | | | 7.8 | Α |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | | | 31.2 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 7.8 A | | | 1.5 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 9.5 A, | | 158 | | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F / dt = 100 A/μs | | 0.97 | | μС |

NOTES

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. L = 5.2 mH, I_{AS} = 7.8 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C.
- 3. I $_{SD} \leq$ 9.5 A, di/dt \leq 300 A/µs, V $_{DD} \leq$ BV $_{DSS,}$ starting $\,$ T $_{J}$ = 25°C.
- 4. Essentially independent of operating temperature.



Typical Characteristics



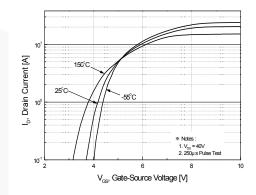
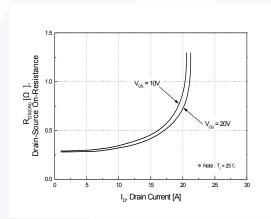


Figure 1. On-Region Characteristics





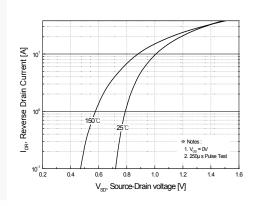
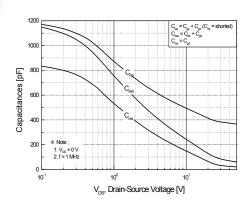


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature



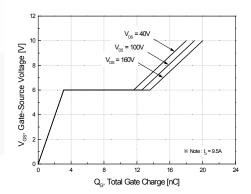
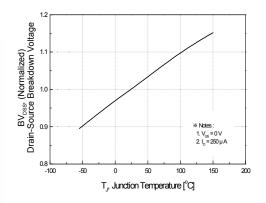


Figure 5. Capacitance Characteristics

Figure 6. Gate Charge Characteristics



Typical Characteristics (Continued)



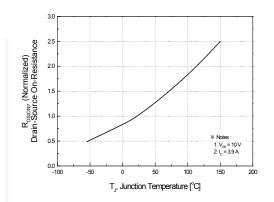


Figure 7. Breakdown Voltage Variation vs Temperature

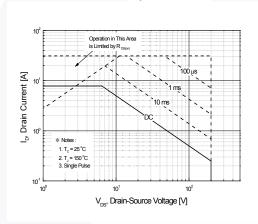


Figure 8. On-Resistance Variation vs Temperature

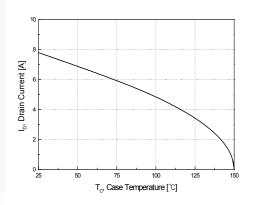
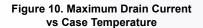


Figure 9. Maximum Safe Operating Area



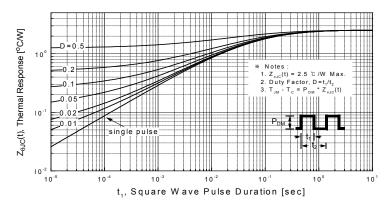


Figure 11. Transient Thermal Response Curve





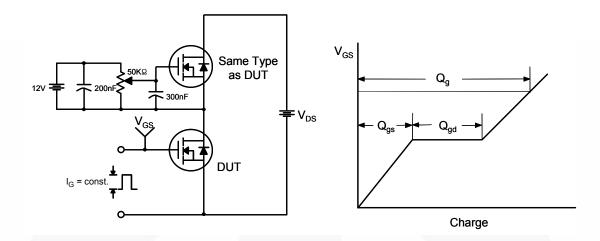


Figure 13. Resistive Switching Test Circuit & Waveforms

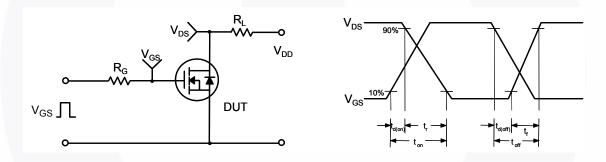
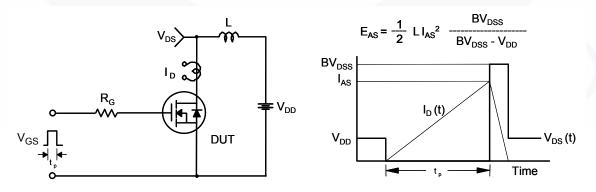
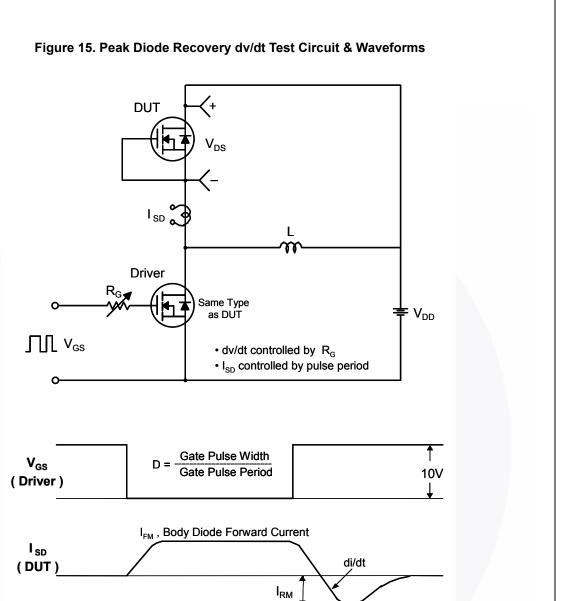
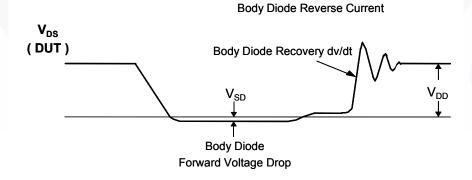


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms









Mechanical Dimensions

TO-252 3L (DPAK)

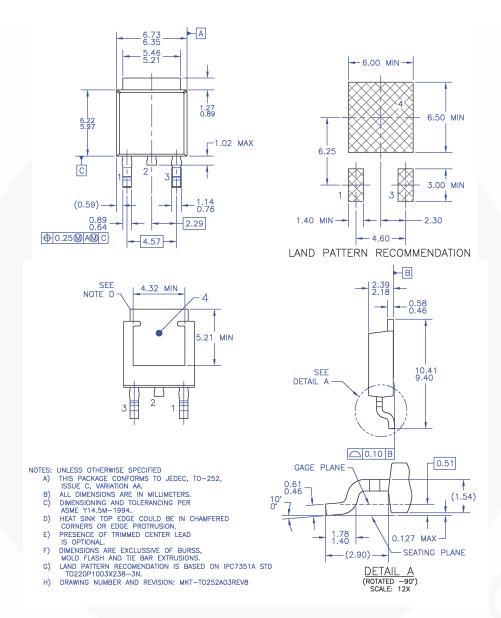


Figure 16. TO252 (D-PAK), Molded, 3 Lead, Option AA&AB

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Dimension in Millimeters



Mechanical Dimensions

TO-251 3L (IPAK)

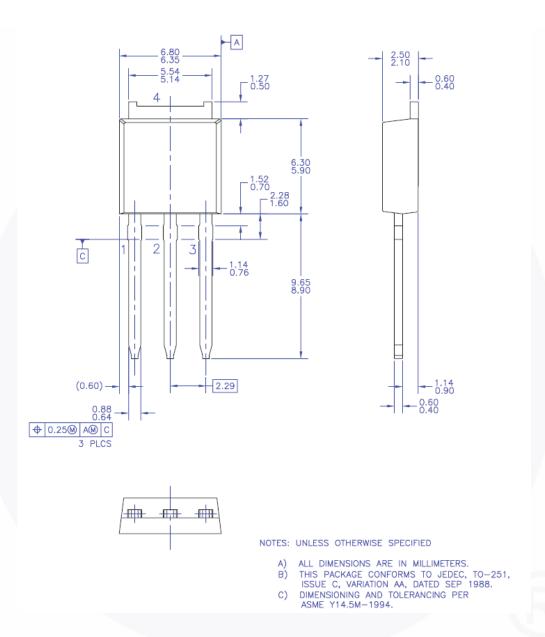


Figure 17. TO251 (IPAK) Molded 3 Lead

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Dimension in Millimeters



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